

Description

MLG60N65FUK is obtained by advanced Trench Field Stop (T-FS) technology which is characteristic with low $V_{CE(sat)}$, optimized switching performance and low gate charge Q_g . The IGBT is suitable device for Photovoltaic, UPS, Boost and high switching frequency applications.

KEY CHARACTERISTICS

Parameter	Value	Unit
V_{CES}	650	V
I_C	60	A
$V_{CE(sat).typ}$	1.6	V

FEATURES

- ① Fast Switching
- ② Low $V_{CE(sat)}$
- ③ Positive temperature coefficient
- ④ Fast recovery anti-parallel diode
- ⑤ RoHS product

APPLICATIONS

- ① Photovoltaic converters
- ② UPS
- ③ Boost

ORDERING INFORMATION

Device Marking	Ordering Codes	Package	Product Code	Packing
60T65FUK	MLG60N65FUK-F	TO-247	G60N65FUK	Tube
	MLG60N65FUK-K	TO-3PF	G60N65FUK	Tube
	MLG60N65FUK-W	TO-3PN	G60N65FUK	Tube

ABSOLUTE RATINGS

Symbol	Parameter	TO-3PN/TO- 247	TO-3PF	Units
V_{CES}	Collector-Emitter Voltage	650	650	V
I_C	Collector Current @ $T_c=25^\circ C$	120	120	A
	Collector Current @ $T_c=100^\circ C$	60	60	A



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I _{CM}	Pulsed Collector Current, tp limited by T _{jmax}	240	240	A
I _F	Diode Continuous Forward Current @T _c =25°C	60	60	A
	Diode Continuous Forward Current @T _c =100°C	30	30	A
I _{FM}	Diode Maximum Forward Current, limited by T _{jmax}	120	120	A
V _{GES}	Gate-Emitter Voltage	±30	±30	V
t _{sc}	Short circuit withstand time V _{GE} =15V, V _{CC} ≤400V, Allowed number of short circuits<1000, Times between short circuits: ≥ 1.0s, T _J ≤ 175°C	10		μs
P _D	Power Dissipation @T _c =25°C	375	62.5	W
T _{jmax} , T _{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175		°C
T _L	Maximum Temperature for Soldering	260		°C

Thermal characteristics

Symbol	Parameter	TO-3PN/TO-247	TO-3PF	Units
R _{θJC}	Junction-to-Case (IGBT)	0.40	2.40	°C/W
R _{θJC}	Junction-to-Case (Diode)	0.75	1.88	°C/W
R _{θJA}	Junction-to-Ambient	40	40	°C/W

Electrical Characteristics at TC = 25°C, unless otherwise specified

Static Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V _{CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250μA	650	--	--	V
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} = 15V, I _C = 60A T _J =25°C T _J =125°C T _J =175°C	-- -- --	1.60 1.95 2.10	2.00 -- --	V
V _{GE(TH)}	Gate Threshold Voltage	V _{CE} = V _{GE} , I _C = 1mA	4.7	5.5	6.2	V
V _F	Diode Forward Voltage	I _F =30A T _J =25°C T _J =125°C T _J =175°C	-- -- --	1.90 1.55 1.40	2.60 -- --	V
I _{CES}	Collector-Emitter Leakage Current	V _{CE} = 650V, V _{GE} = 0V	--	--	25	μA
I _{GES(F)}	Gate-Emitter Forward Leakage Current	V _{GE} = +30V	--	--	200	nA



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I _{GES(R)}	Gate-Emitter Reverse Leakage Current	V _{GE} = -30V	--	--	-200	nA
Pulse width t _p ≤300μs, δ≤2%						

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GE} =0V V _{CE} =25V f=1.0MHz	--	3146	--	pF
C _{oss}	Output Capacitance		--	121	--	
C _{rss}	Reverse Transfer Capacitance		--	31	--	
Q _G	Gate charge	V _{CC} =520V I _{CE} =20A V _{GE} =15V	--	118	--	nC
Q _{GC}	Gate-emitter charge		--	46	--	
Q _{GE}	Gate-collector charge		--	33	--	
I _{C(SC)}	Short circuit collector current Max.1000 short circuits, Times between short circuits: ≥ 1.0s	V _{GE} =15.0V, V _{CC} ≤400V, t _{sc} ≤10us, T _J ≤175°C		250		A

IGBT Switching Characteristics, at T_J=25 °C

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
t _{d(on)}	Turn-on Delay Time	I _C =60A V _{CE} = 400V V _{GE} = 15V R _G =5Ω T _J =25°C Inductive Load	--	40	--	ns
t _r	Rise Time		--	47	--	
t _{d(off)}	Turn-Off Delay Time		--	123	--	
t _f	Fall Time		--	90	--	
E _{on}	Turn-On Switching Loss		--	1.20	--	mJ
E _{off}	Turn-Off Switching Loss		--	1.50	--	
E _{ts}	Total Switching Loss		--	2.70	--	

IGBT Switching Characteristics, at T_J=175 °C

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
t _{d(on)}	Turn-on Delay Time	I _C =60A V _{CE} = 400V V _{GE} = 15V R _G =5Ω T _J =175°C Inductive Load	--	35	--	ns
t _r	Rise Time		--	44	--	
t _{d(off)}	Turn-Off Delay Time		--	139	--	
t _f	Fall Time		--	154	--	
E _{on}	Turn-On Switching Loss		--	1.26	--	



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E _{off}	Turn-Off Switching Loss		--	2.30	--	
E _{ts}	Total Switching Loss		--	3.56	--	

Diode Characteristics, at TJ=25 °C

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T _{rr}	Reverse Recovery Time	I _F =30A, di/dt=200A/μs, T _J =25°C	--	52	--	ns
Q _{rr}	Reverse Recovery Charge		--	62	--	nC
I _{rrm}	Reverse Recovery Current		--	3.07	--	A
T _{rr}	Reverse Recovery Time	I _F =60A, di/dt=200A/μs, T _J =25°C	--	69	--	ns
Q _{rr}	Reverse Recovery Charge		--	76	--	nC
I _{rrm}	Reverse Recovery Current		--	3.64	--	A

Diode Characteristics, at TJ=175 °C

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
T _{rr}	Reverse Recovery Time	I _F =30A, di/dt=200A/μs, T _J =175°C	--	154	--	ns
Q _{rr}	Reverse Recovery Charge		--	655	--	nC
I _{rrm}	Reverse Recovery Current		--	7.72	--	A
T _{rr}	Reverse Recovery Time	I _F =60A, di/dt=200A/μs, T _J =175°C	--	175	--	ns
Q _{rr}	Reverse Recovery Charge		--	670	--	nC
I _{rrm}	Reverse Recovery Current		--	7.96	--	A

Characteristics Curves

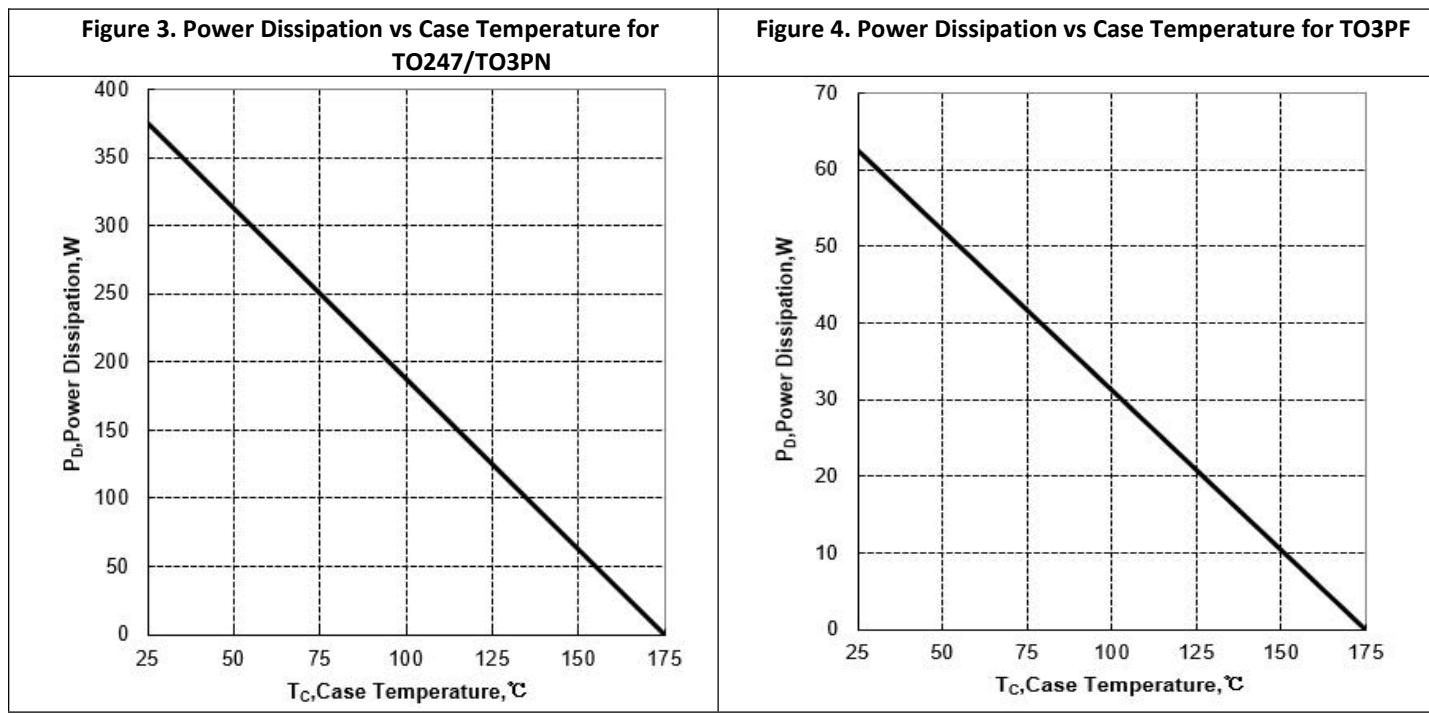
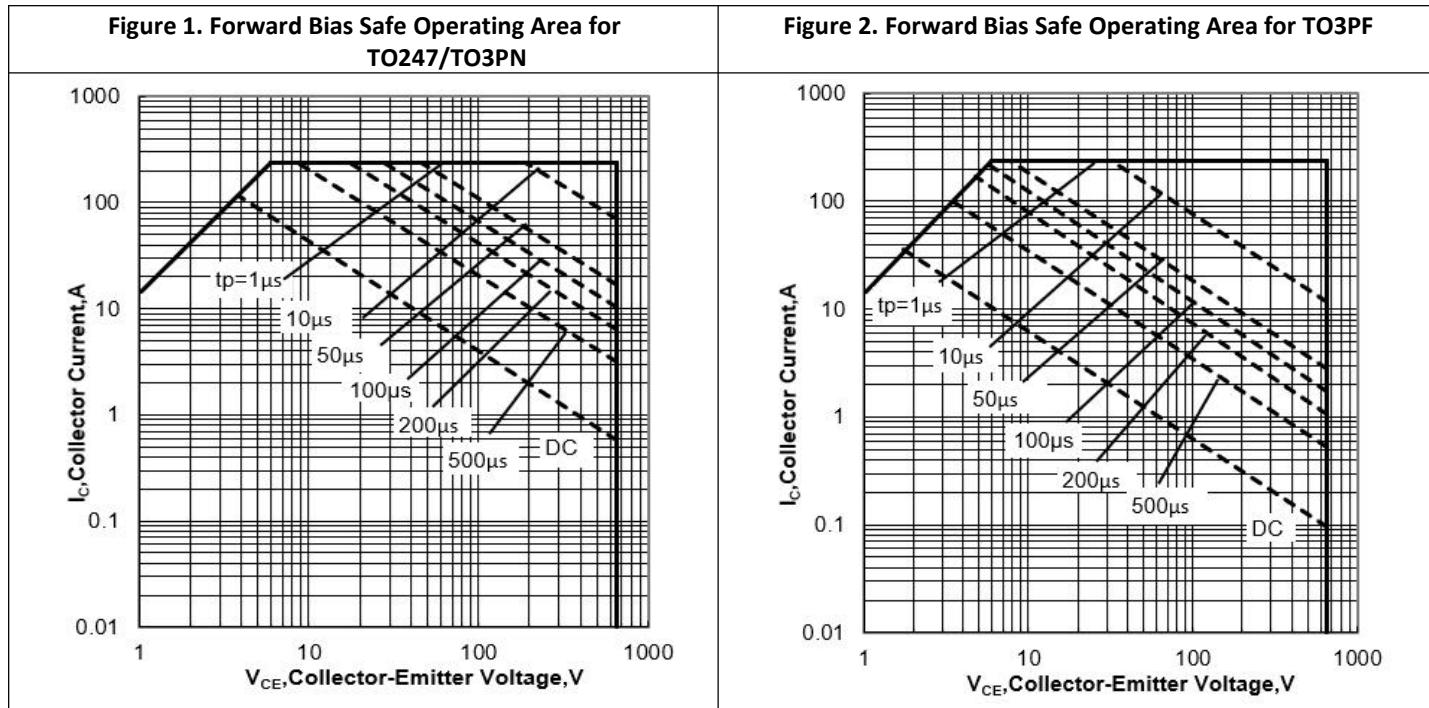


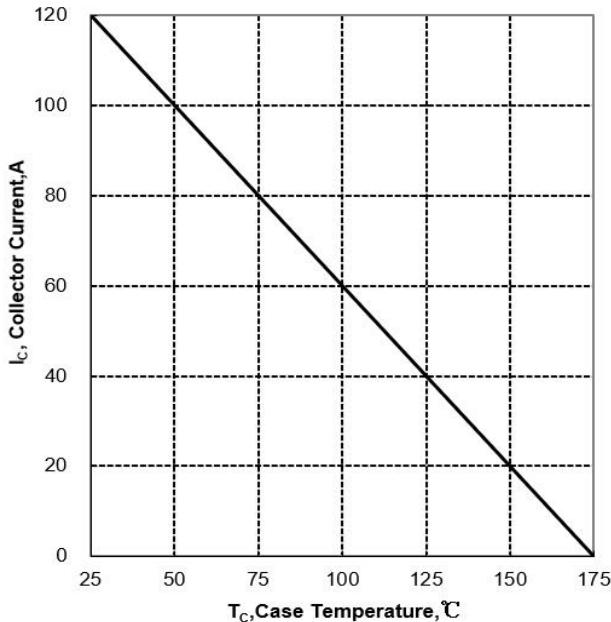
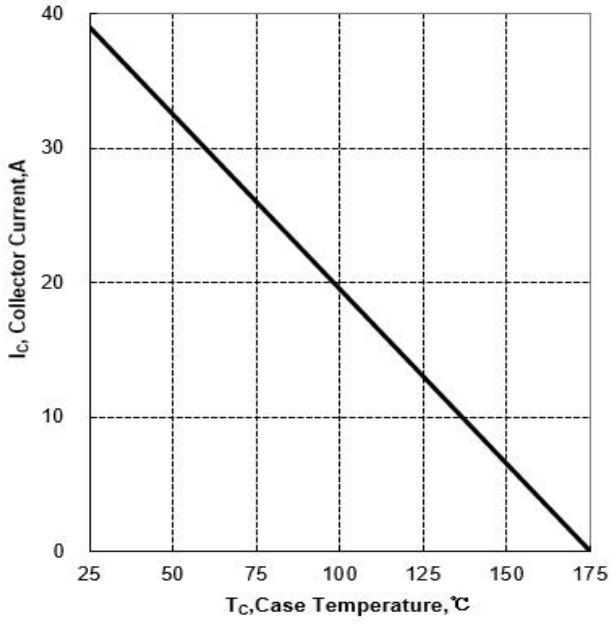
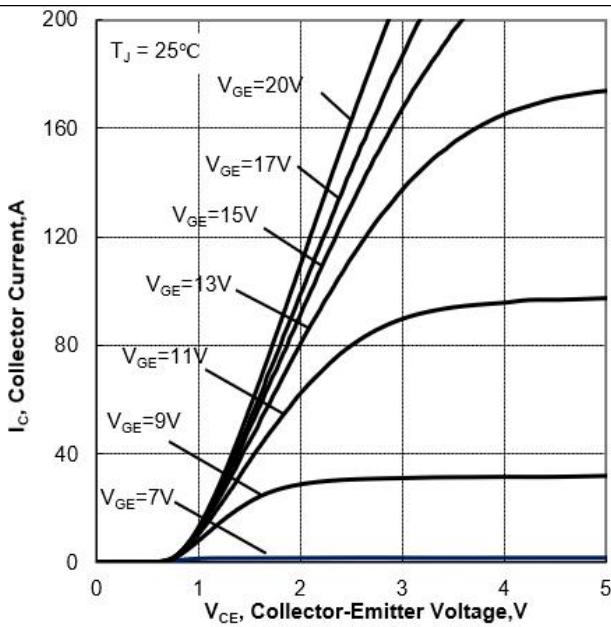
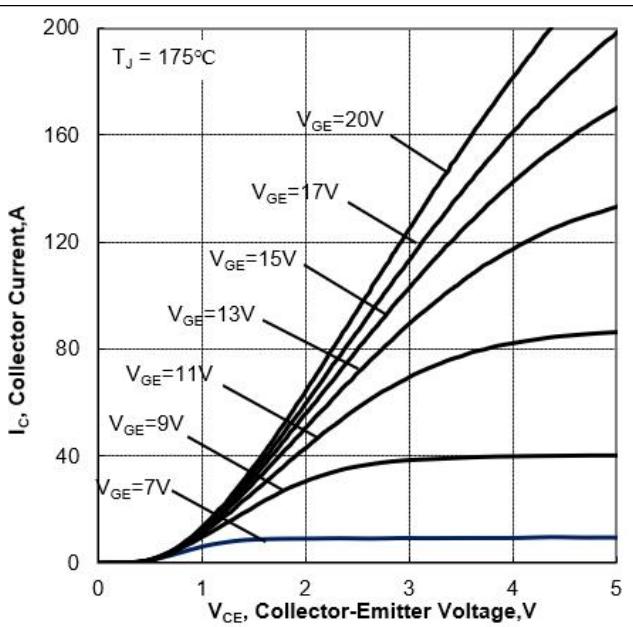
Figure 5. Collector Current vs Case Temperature for TO247/TO3PN

Figure 6. Collector Current vs Case Temperature for TO3PF

Figure 7. Typical Output Characteristics ($T_J=25^\circ\text{C}$)

Figure 8. Typical Output Characteristics ($T_J=175^\circ\text{C}$)


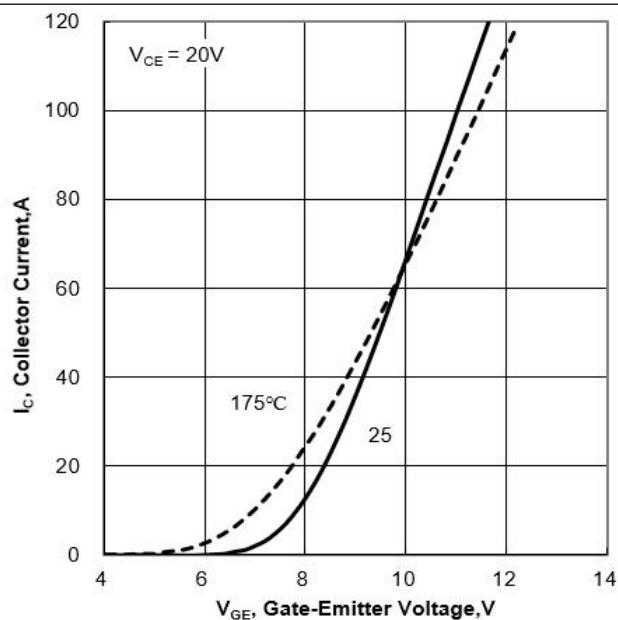
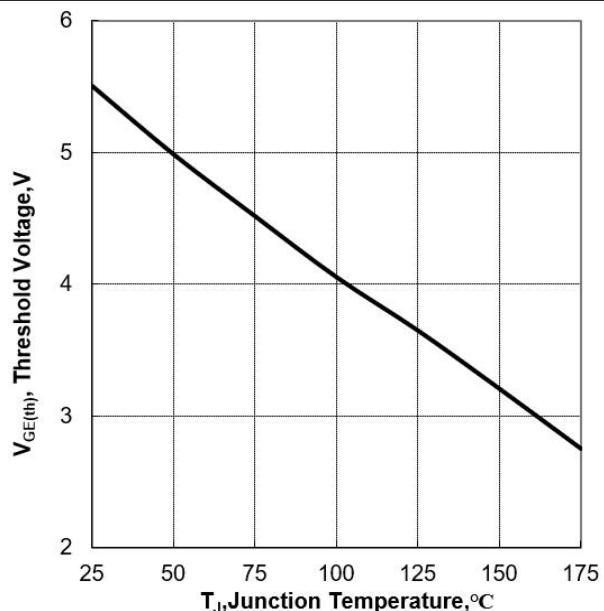
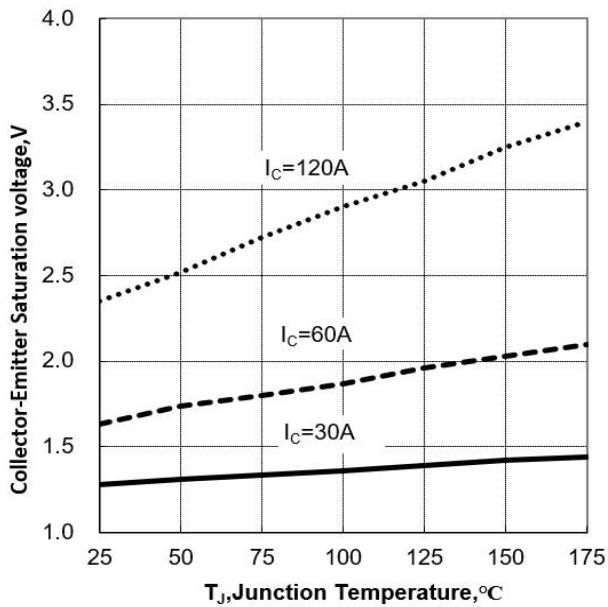
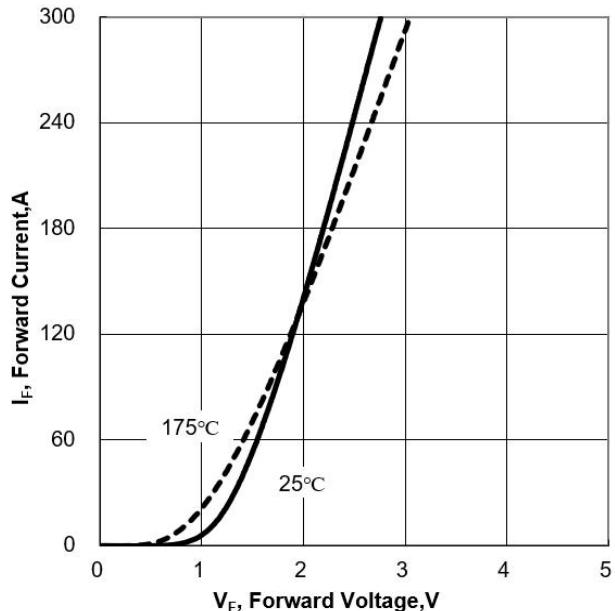
Figure 9. Typical Transfer Characteristics

Figure 10. Typical Gate-Emitter Threshold Voltage vs Junction Temperature

Figure 11. Typical Collector-Emitter Saturation Voltage vs Junction Temperature

Figure 12. Typical Diode Forward Current vs Forward Voltage


Figure 13. Typical Switching Times vs Gate Resistor
 $(T_J=25^\circ\text{C}, V_{CE}=400\text{V}, V_{GE}=15/0\text{V}, I_c=60\text{A})$

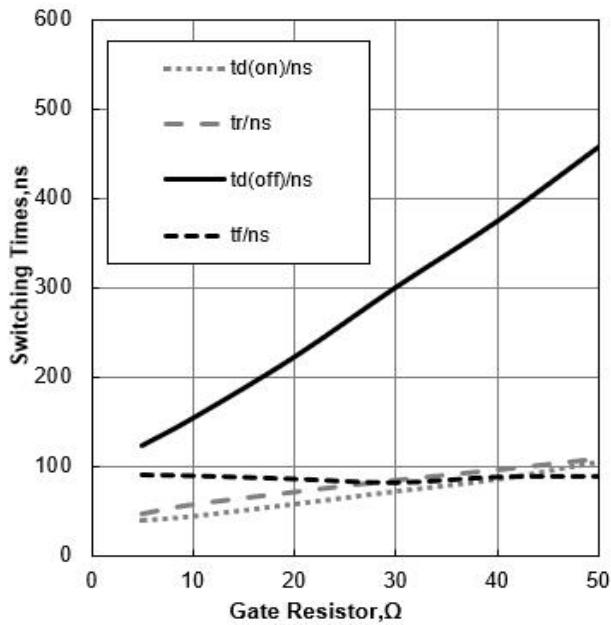


Figure 14. Typical Switching Energy vs Gate Resistor
 $(T_J=25^\circ\text{C}, V_{CE}=400\text{V}, V_{GE}=15/0\text{V}, I_c=60\text{A})$

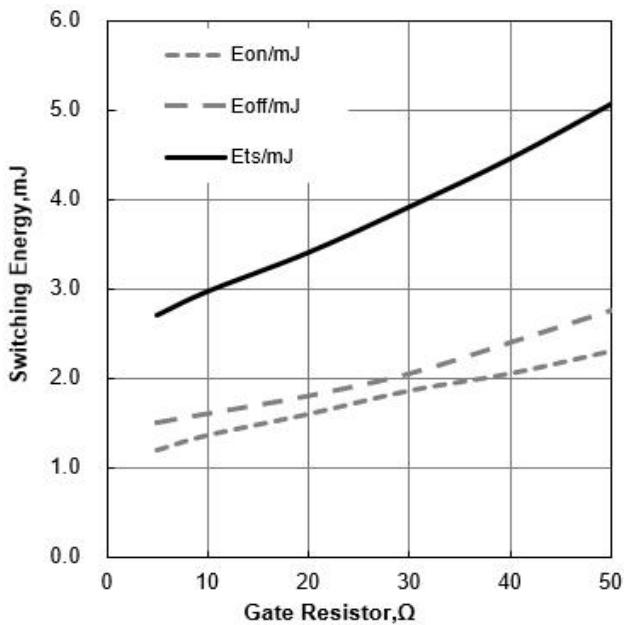


Figure 15. Typical Switching Times vs Junction Temperature
 $(V_{CE}=400\text{V}, V_{GE}=15/0\text{V}, I_c=60\text{A})$

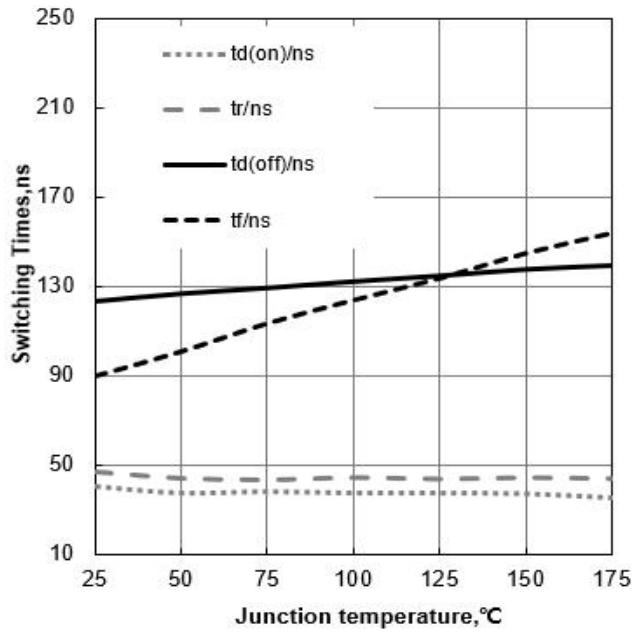


Figure 16. Typical Switching Energy vs Junction Temperature
 $(V_{CE}=400\text{V}, V_{GE}=15/0\text{V}, I_c=60\text{A})$

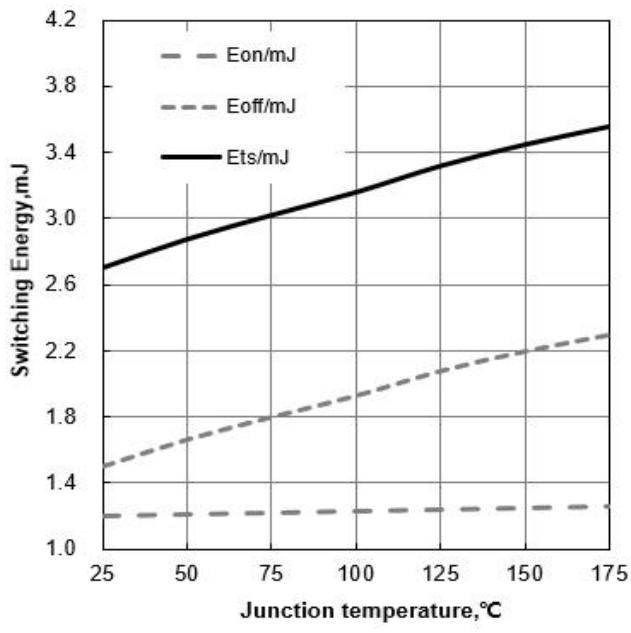


Figure 17. Typical Switching Times vs Collector Current
 $(T_J=25^\circ\text{C}, V_{CE}=400\text{V}, V_{GE}=15/0\text{V})$

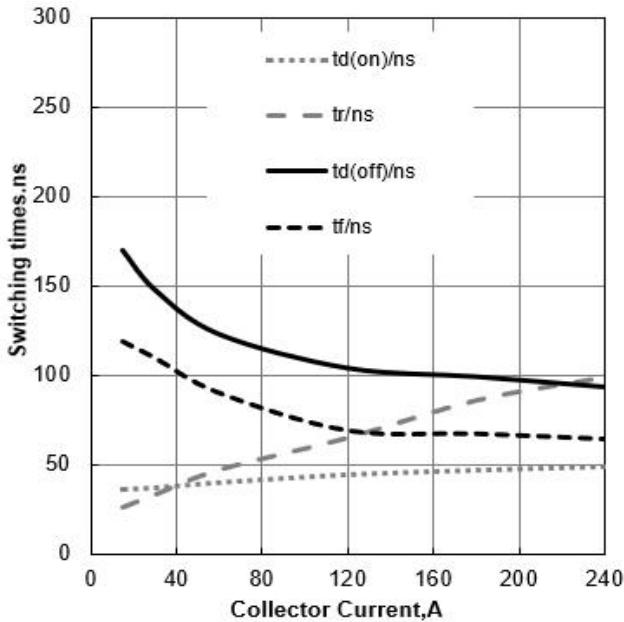


Figure 18. Typical Switching Energy vs Collector Current
 $(T_J=25^\circ\text{C}, V_{CE}=400\text{V}, V_{GE}=15/0\text{V})$

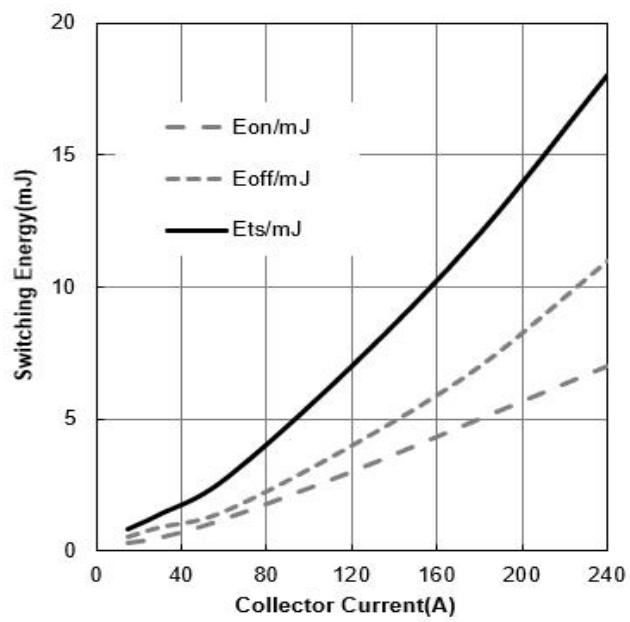


Figure 19. Typical Switching Times vs V_{CE}
 $(T_J=25^\circ\text{C}, V_{GE}=15/0\text{V}, I_c=60\text{A})$

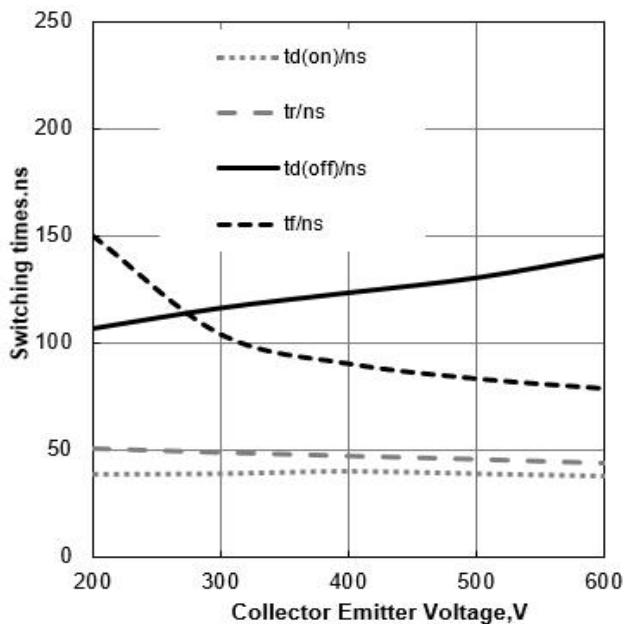


Figure 20. Typical Switching Energy vs V_{CE} ($T_J=25^\circ\text{C}$, $V_{GE}=15/0\text{V}$, $I_c=60\text{A}$)

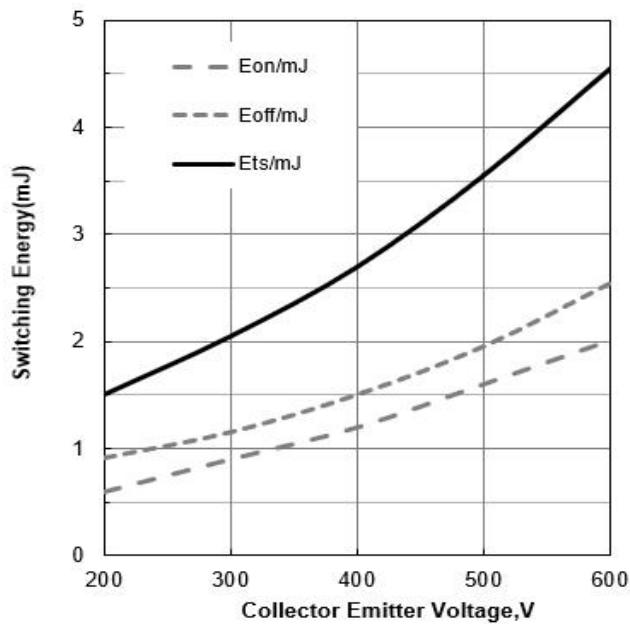


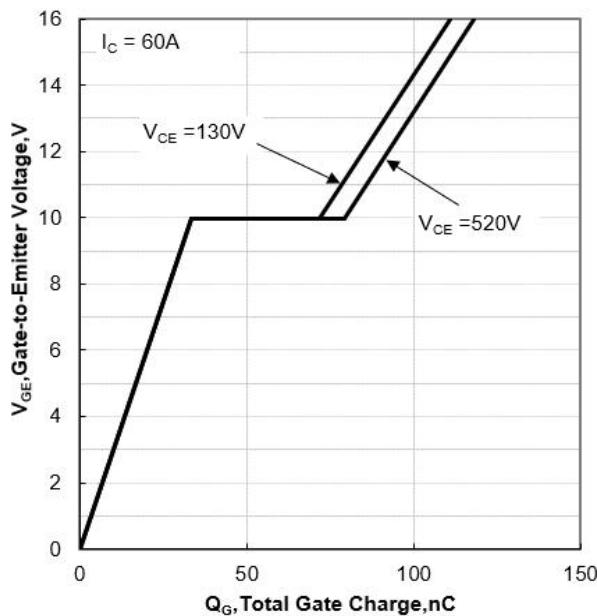
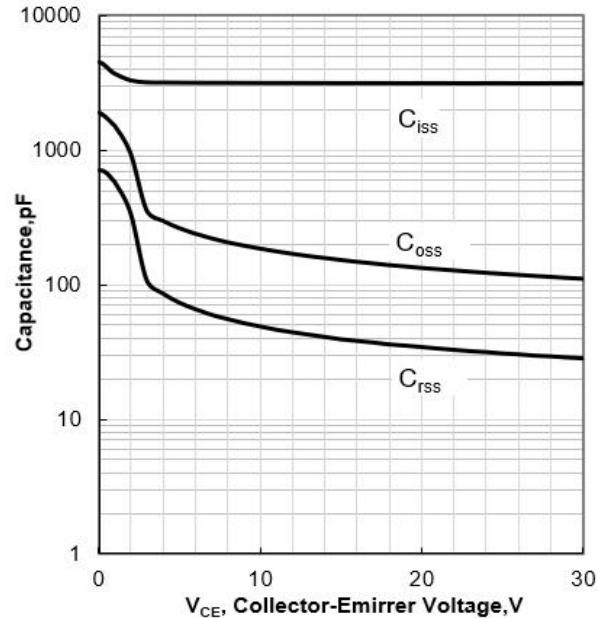
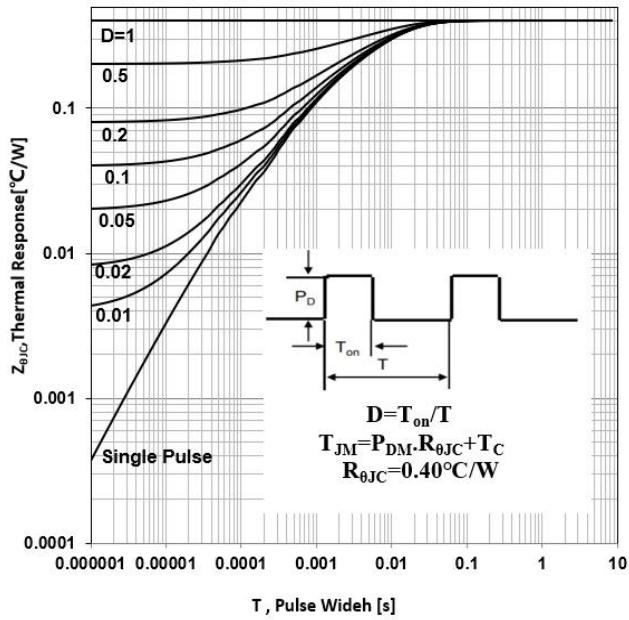
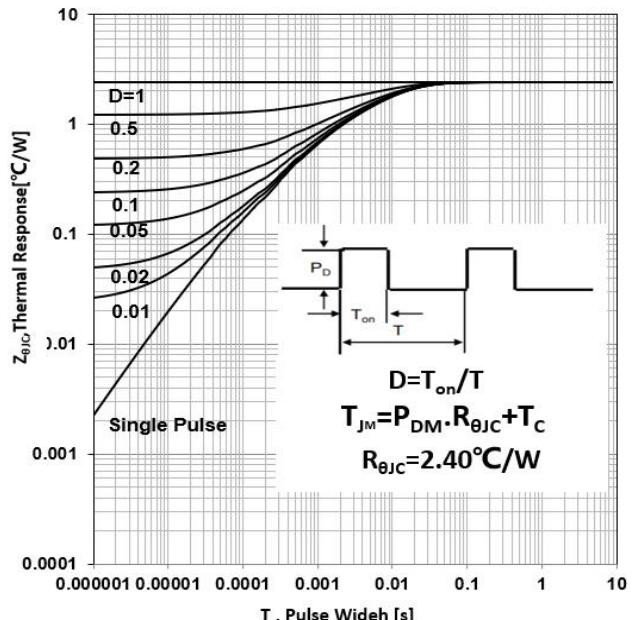
Figure 21. Typical Gate Charge

Figure 22. Typical Capacitance vs Collector- Emitter Voltage

Figure 23. IGBT Transient Thermal Impedance vs Pulse Width(TO247/TO3PN)

Figure 24. IGBT Transient Thermal Impedance vs Pulse Width(TO3PF)


Figure 25. Diode Transient Thermal Impedance vs Pulse Width(TO247/TO3PN)

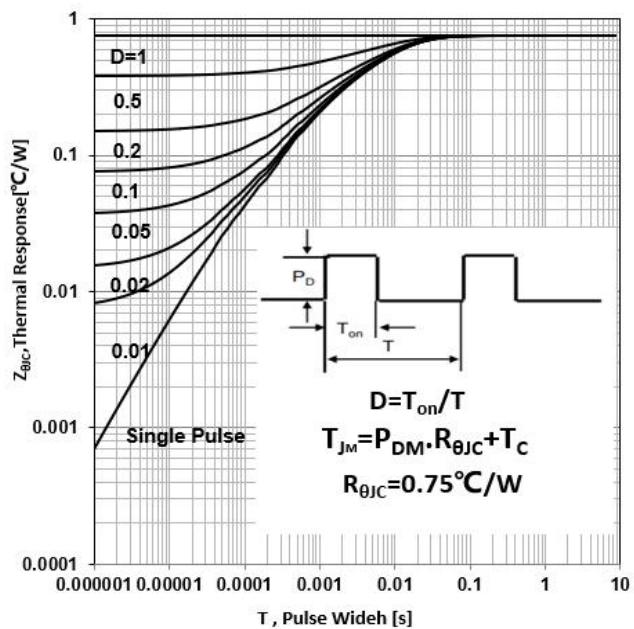
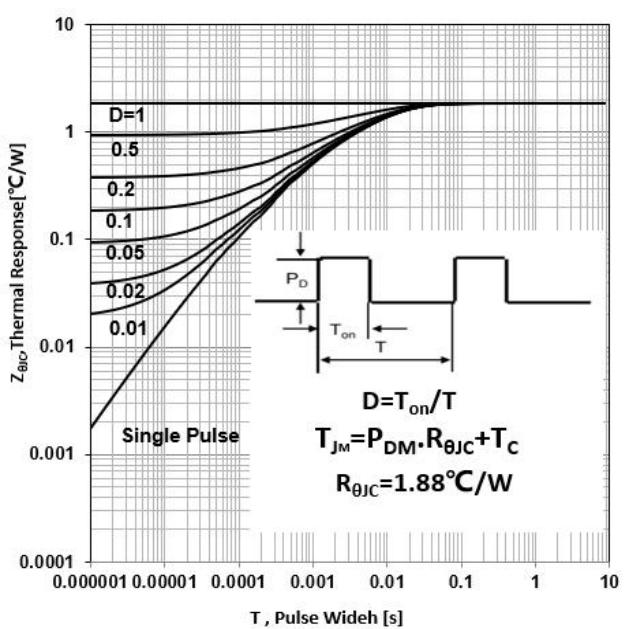
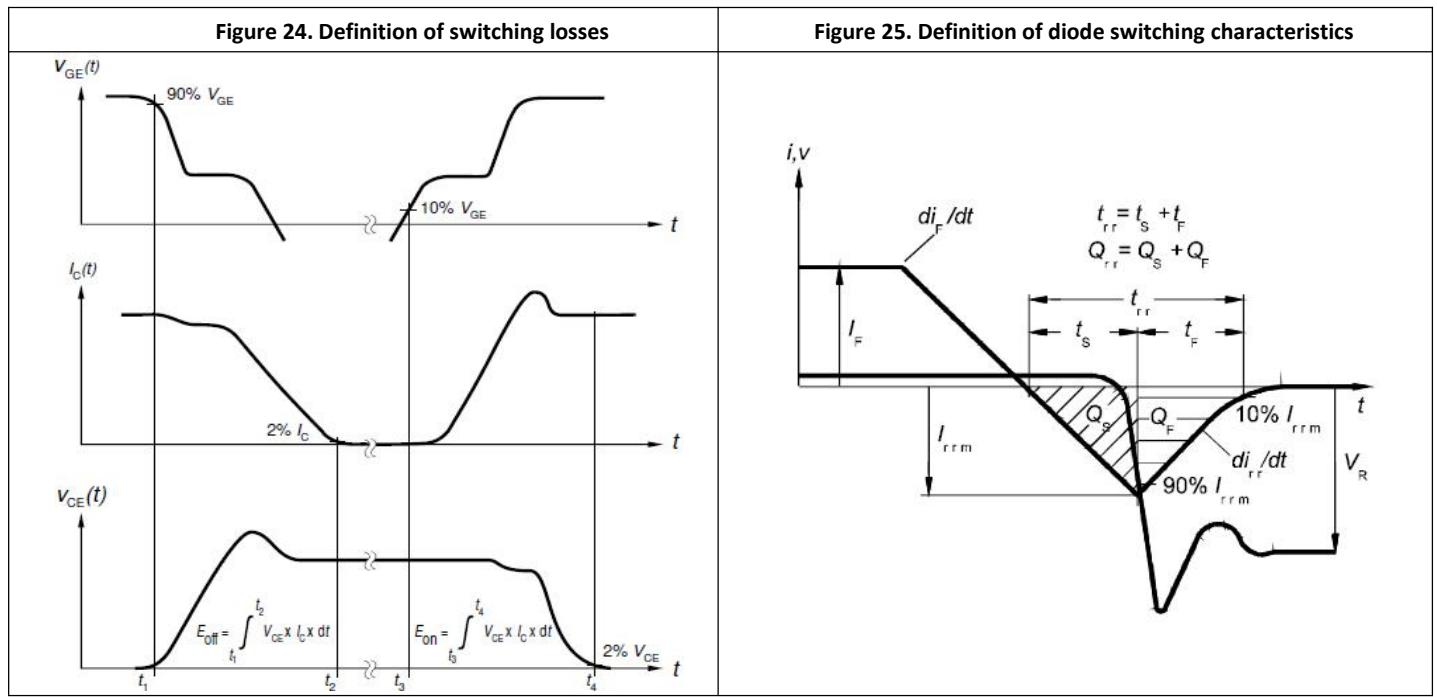
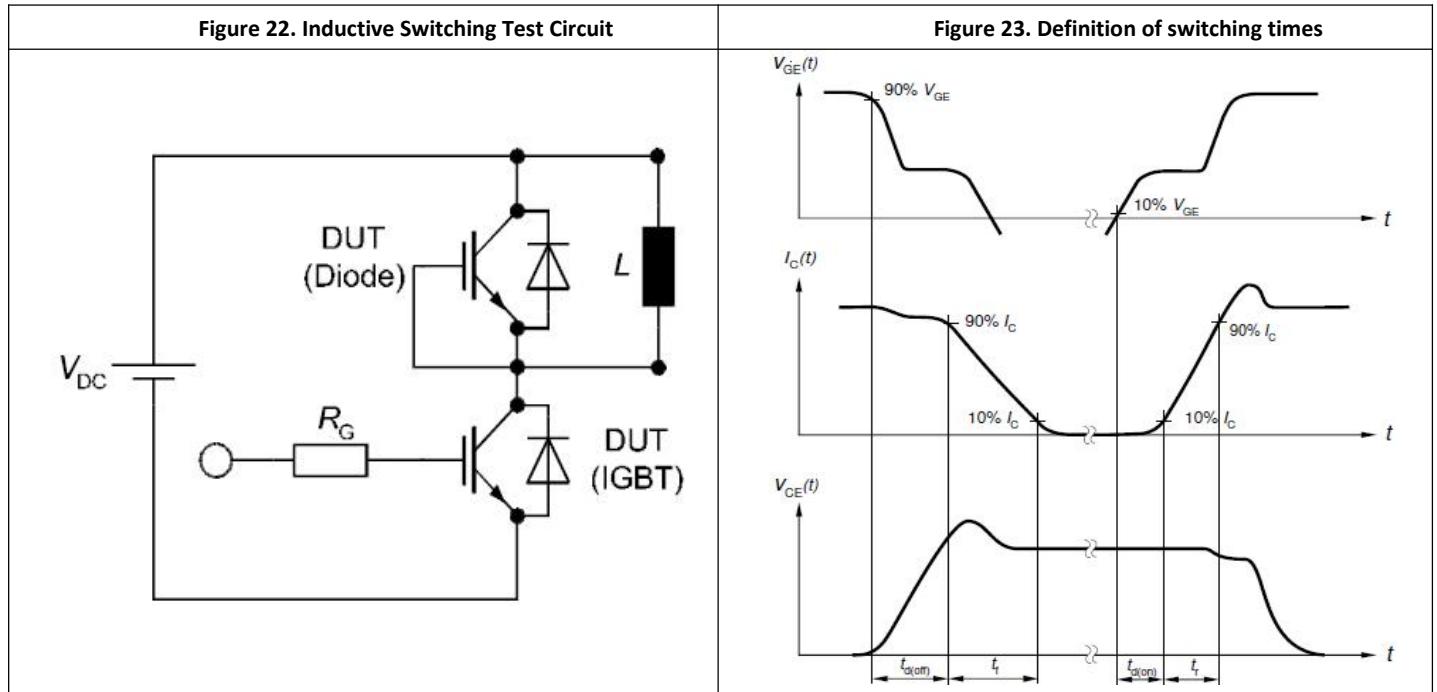


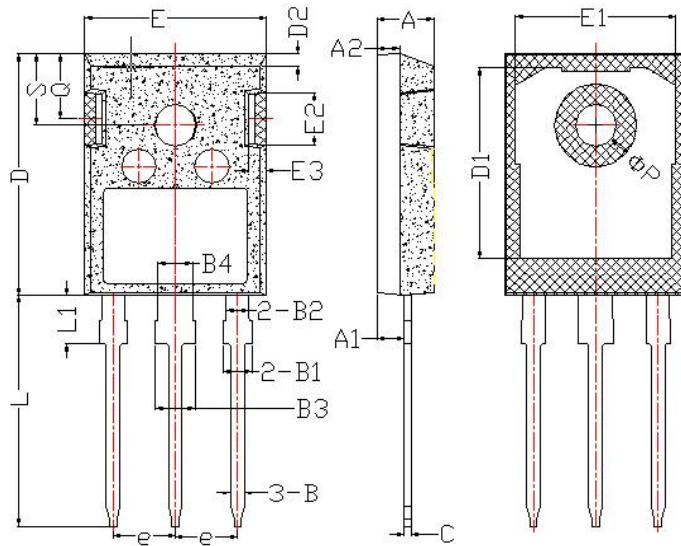
Figure 26. Diode Transient Thermal Impedance vs Pulse Width (TO3PF)



Test Circuit and Waveform

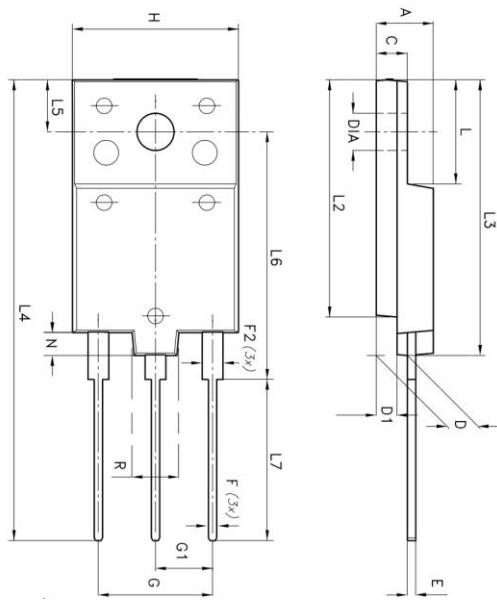


Package Description



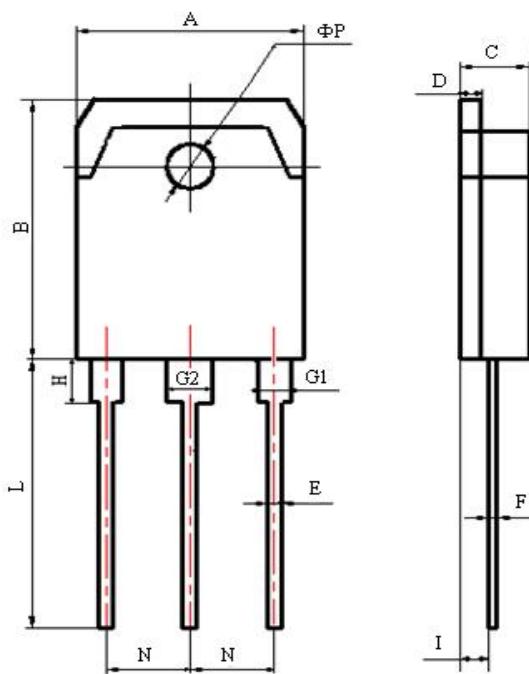
Items	Values (mm)	
	MIN	MAX
A	4.90	5.16
A1	2.27	2.53
A2	1.85	2.11
B	1.07	1.33
B1	1.90	2.41
B2	1.75	2.15
B3	2.87	3.38
B4	2.87	3.13
C	0.55	0.68
D	20.82	21.10
D1	16.25	17.65
D2	1.05	1.35
E	15.70	16.03
E1	13.10	14.15
E2	3.68	5.10
E3	1.68	2.60
e	5.44	
L	19.80	20.31
L1	4.17	4.47
ΦP	3.50	3.70
Q	5.49	6.00
S	6.04	6.30

TO-247 package



Items	Values (mm)	
	MIN	MAX
A	5.30	5.70
C	2.80	3.20
D	3.10	3.50
D1	1.80	2.20
E	0.80	1.10
F	0.65	0.95
F2	1.80	2.20
G	10.30	11.50
G1	5.45	
H	15.30	15.70
L	9.80	10.20
L2	22.80	23.20
L3	26.30	26.70
L4	43.20	44.40
L5	4.3	4.70
L6	24.3	24.70
L7	14.6	15
N	1.8	2.2
R	3.8	4.2
Dia	3.4	3.8

TO-3PF package



Items	Values (mm)	
	MIN	MAX
A	15.00	16.00
B	19.20	20.60
C	4.60	5.00
D	1.40	1.60
E	0.90	1.10
F	0.50	0.70
G1	2.00	2.20
G2	3.00	3.20
H	3.00	3.70
I	1.20	1.70
	2.70	2.90
L	19.00	21.00
N	5.25	5.65
ΦP	3.10	3.30

TO-3PN package



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NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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